

**Search Notes**

Application/Control No.

10/091,100

Examiner

Utpal D. Shah

Applicant(s)/Patent under  
Reexamination

LI ET AL.

Art Unit

2625

**SEARCHED**

Class	Subclass	Date	Examiner
382	118, 205	1/19/2006	US
382	159,181	1/19/2006	US

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPub Text search Interferenc search printout		1/19/2006	US

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/118,205 (text search, see report)	9/23/2005	US
East Search (see report)	9/23/2005	US
IEEE explore (multi-view, face , detection)	9/23/2005	US
updated east search ( see report)	1/19/2006	US
Updated IEEE (see print out)	1/19/2006	US
Google Scholar (see print out)	1/19/2006	US
Conslt. Wenpeng Chen	1/17/2006	US
Inventor Search (see report)	1/19/2006	US